

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
09/749,175	BOWDEN ET AL.	
Examiner	Art Unit	
Jason T. Whinkey	2612	

	SEARCHED			
Class	Subclass	Date	Examiner	
			,	
			-	
<u>-</u>				

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Text search	6/26/05	Whipk
Dialog search	6/2/05	
Updated search	6/29/05	1
•		